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09/703845



Class	Subclass	ISSUE CLASSIFICATION

U.S. UTILITY Patent Application

M.R. SCANNED	O.I.P.E. A	PATENT DATE O.A. A.G.
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APPLICATION NO. 09/703845	CONT/PRIOR	CLASS 324	SUBCLASS 658	ART UNIT 2858	EXAMINER T. R. SUNDARANI
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APPLICANTS

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HOLLINGTON

TITLE

Capacitance measurement method of micro structures of integrated circuits

PTO-2040
12/99

ISSUING CLASSIFICATION

ORIGINAL		CROSS REFERENCE(S)						
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
INTERNATIONAL CLASSIFICATION								

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<input type="checkbox"/> TERMINAL DISCLAIMER	DRAWINGS			CLAIMS ALLOWED	
	Sheets Drwg.	Figs. Drwg.	Print Fig.	Total Claims	Print Claim for O.G.
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<input type="checkbox"/> The term of this patent shall not extend beyond the expiration date of U.S. Patent No. _____.				ISSUE FEE	
				Amount Due	Date Paid
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